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WINSTAR Display

OLED SPECIFICATION

Model No:

WEO012864GLPP3D00000

CUSTOMER:

MODULE NO.: WEO012864GLPP3D00000

APPROVED BY:

(FOR CUSTOMER USE ONLY)

SALES BY	APPROVED BY CHECKED BY	PREPARED BY
SALES BT	AFFROVED BY CHECKED BY	FREFARED BT
RELEASE DATE		

- APPROVAL FOR SPECIFICATIONS ONLY
- **PAPPROVAL FOR SPECIFICATIONS AND SAMPLE**

MODEL NO:

RECORDS OF REVISION			DOC. FIRST ISSUE
VERSION	DATE	REVISED PAGE NO.	SUMMARY
0	2018/07/02		First release
А	2018/11/09		Add 6.3.3 Register Map
В	2018/12/03		Modify Static electricity test Content of Test

Contents

- 1. Module Classification Information
- 2.General Specification
- 3. Contour Drawing & Block Diagram
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- 9.Reliability
- 10.Inspection specification
- 11.Precautions in use of OLED Modules

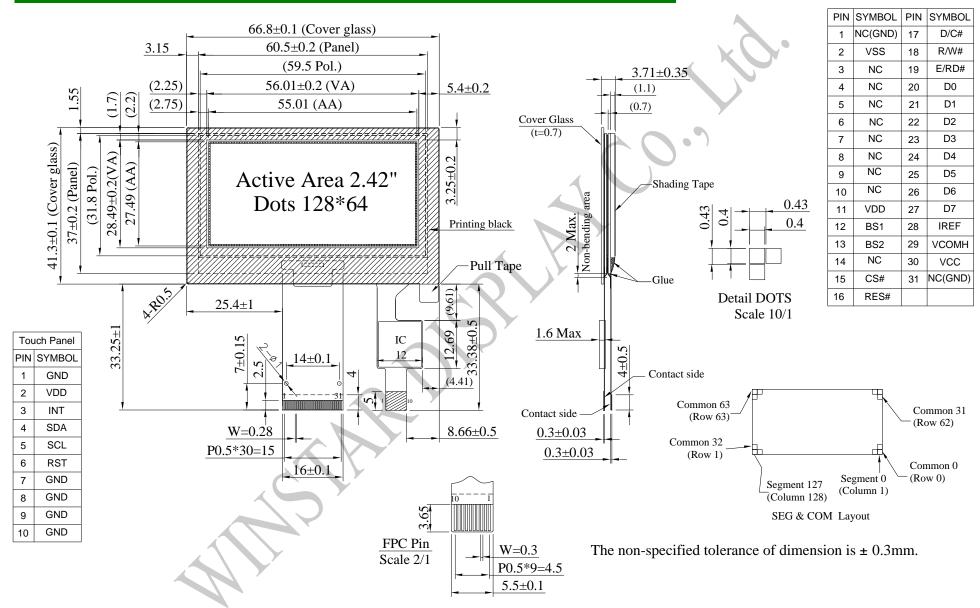
1.Module Classification Information

1	Brand: WINSTAR DISPLAY CORPORATION							
2	E: OLED							
		H: COB Character	G: COB Graphic					
	Diamin. T	O: COG	F: COG + FR	XO				
3	Display Type	P:COG+FR+PCB	X : TAB					
		A: COG + PCB						
4	Dot Matrix: 12	28 * 64	40					
5	Serials code							
		A: Amber	R: Red	C: Full Color				
6	Emitting Color	B: Blue	W: White					
	Limiting Color	G: Green	L: Yellow					
		S: Sky Blue	X : Dual Color					
7	Polarizer	P: With Polarizer; N: V						
8	Dianlay Mada	A : Anti-glare Polarizer P : Passive Matrix ; N						
9	Display Mode Driver Voltage	3: 3.0~3.3V ; 5:5.						
			el; T:Resistive TP; D:[OCT Attached CTP:				
10	Touch Panel	-	P; A: OCA Attached CTF					
		0 : Standard						
		1 : Daylight Readable	 ,					
11	Product type	2 : Transparent OLED (TOLED)						
		4 : OLED Lighting	3 : Flexible OLED (FOLED)					
		0 : Standard						
40	Inspection	2 : Special grade						
12	Grade	C: Automotive grade	, ·					
	N	Y: Consumer grade	Y : Consumer grade					
13	Option	· ·	0 : Default ; F : ZIF FPC ; H : Hot bar FPC; D : Demo Kit					
14	Serial No.	Serial number(00~ZZ)						

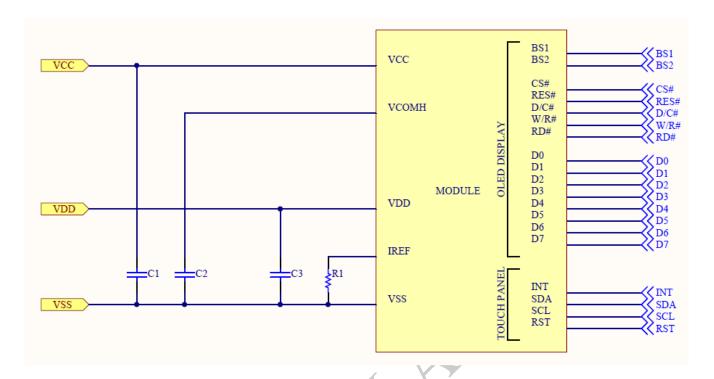
2.General Specification

Item	Dimension	Unit				
Dot Matrix	128 x 64	_				
Module dimension	66.8 × 41.3 × 3.71	mm				
Active Area	55.01 × 27.49	mm				
Pixel Size	0.40 × 0.40	mm				
Pixel Pitch	0.43 × 0.43	mm				
Display Mode	Passive Matrix	9.				
Display Color	Monochrome (Yellow)					
Interface	8Bits 68xx 80xx/ SPI/ I2C					
Drive Duty	1/64 Duty					
OLED IC	SSD1309					
Size	2.42inch					
CTP IC	GT911					
Detect Point	1					
CTP Interface	I2C					
CTP FW Version:	VER95					
Surface	Normal Glare					

3. Contour Drawing & Block Diagram



3.1 Application recommendations



Recommended components:

C1, C2: 4.7uF/25V/0805 C3: 1.0uF/16V/0603

OLED DISPLAY's Bus Interface selection: (Must be set the BS[2:1], refer to item 4) 8-bits 6800 and 8080 parallel, SPI, I2C

TOUCH PANEL'S INTERFACE: ONLY I2C INTERFACE.

Voltage at IREF \approx VCC - 3V. For VCC = 13V, IREF = 10uA: R1 = (Voltage at IREF - VSS) / IREF \approx (13 - 3)V / 10uA = 1M Ω

^{*}For more information, please refer to Application Note provided by Winstar.

4. Interface Pin Function

No.	Symbol	Function				
1	NC(GND)	No connection				
2	VSS	Ground.				
3-10	NC	No connection				
11	VDD	Power supply pin for core logic operation				
12	BS1	MCU bus interface selection pins. Select appropriate logic setting as described in the following table. BS2, BS1 and BS0 are pin select BS1 BS2 I 2 C 1 0 0 1 1 1 1 1 1				
		4-wire Serial 0 0				
		8-bit 68XX Parallel 0 1				
13	BS2	8-bit 80XX Parallel 1 1 Note (1) 0 is connected to VSS (2) 1 is connected to VDD				
14	NC	No connection				
15	CS#	This pin is the chip select input connecting to the MCU. The chip is enabled for MCU communication only when CS# is pulled LOW (active LOW).				
16	RES#	This pin is reset signal input. When the pin is pulled LOW, initialization of the chip is executed. Keep this pin pull HIGH during normal operation.				
17	D/C#	This pin is Data/Command control pin connecting to the MCU. When the pin is pulled HIGH, the data at D[7:0] will be interpreted as data. When the pin is pulled LOW, the data at D[7:0] will be transferred to a command register. In I2C mode, this pin acts as SA0 for slave address selection. When 3-wire serial interface is selected, this pin must be connected				
18	R/W#	This pin is read / write control input pin connecting to the MCU interface. When 6800 interface mode is selected, this pin will be used as Read/Write (R/W#) selection input. Read mode will be carried out when this pin is pulled HIGH and write mode when LOW. When 8080 interface mode is selected, this pin will be the Write (WR#) input. Data write operation is initiated when this pin is pulled LOW and the chip is selected. When serial or I2C interface is selected, this pin must be connected				

19	E/RD#	This pin is MCU interface input. When 6800 interface mode is selected, this pin will be used as the Enable (E) signal. Read/write operation is initiated when this pin is pulled HIGH and the chip is selected. When 8080 interface mode is selected, this pin receives the Read (RD#) signal. Read operation is initiated when this pin is pulled LOW and the chip is selected. When serial or I2C interface is selected, this pin must be connected to VSS.
20~27	D0~D7	These pins are bi-directional data bus connecting to the MCU data bus. Unused pins are recommended to tie LOW. When serial interface mode is selected, D0 will be the serial clock input: SCLK; D1 will be the serial data input: SDIN and D2 should be kept NC. When I2C mode is selected, D2, D1 should be tied together and serve as SDAout, SDAin in application and D0 is the serial clock input, SCL.
28	IREF	This pin is the segment output current reference pin. IREF is supplied externally.
29	VCOMH	COM signal deselected voltage level. A capacitor should be connected between this pin and VSS.
30	VCC	Power supply for panel driving voltage. This is also the most positive power voltage supply pin.
31	NC(GND)	No connection

CTP PIN Definition

No.	Symbol	Function
1	GND	Power ground
2	VDD	Power supply
3	INT	Interrupt signal, active low, asserted to request Host start a new transaction
4	SDA	I2C data signal
5	SCL	I2C clock signal
6	RST	External reset signal, active low
7	GND	Power ground
8	GND	Power ground
9	GND	Power ground
10	GND	Power ground

5.Absolute Maximum Ratings

Parameter	Symbol	Min	Max	Unit	Notes
Supply Voltage for Logic	VDD	-0.3	3.47	V	1, 2
Supply Voltage for Display	VCC	0	15	V	1, 2
Operating Temperature	TOP	-20	+70	°C	Q.
Storage Temperature	TSTG	-30	+80	°C	-

Note 1: All the above voltages are on the basis of "VSS = 0V".

Note 2: When this module is used beyond the above absolute maximum ratings, permanent breakage of the module may occur. Also, for normal operations, it is desirable to use this module under the conditions according to Section 6 "Electrical Characteristics". If this module is used beyond these conditions, malfunctioning of the module can occur and the reliability of the module may deteriorate

6.Electrical Characteristics

6.1 DC Electrical Characteristics

Item	Symbol	Condition	Min	Тур	Max	Unit
Supply Voltage for Logic	VDD	_	2.8	3.0	3.3	٧
Supply Voltage for Display	VCC	_	12.5	13 🗸	13.5	V
High Level Input	VIH	_	0.8×VDD	_		V
Low Level Input	VIL	_	-	G.	0.2×VDD	V
High Level Output	VOH	_	0.9×VDD)_	_	V
Low Level Output	VOL	_	1	_	0.1×VDD	V
50% Check Board operating Current		VCC =13.0V	-	22	33	mA

6.2 OLED DISPLAY's Initial code

void Initial_SSD1309ZC(){

```
Write_command(0xAE);
                           // Display Off
Write command(0xAD);
                           // Master Configuration
Write command(0x8e);
                           // Select external VCC supply
Write command(0xA8);
                           // Select Multiplex Ratio
                                                      0x1F(1/32 Duty)
Write command(0x3F); // Default => 0x3F (1/64 Duty)
Write_command(0xD3); //Setting Display Offset
Write command(0x00):
                           //00H Reset
Write_command(0x00); //Set Column Address LSB
Write command(0x10); //Set Column Address MSB
Write command(0x40);
                           //Set Display Start Line
Write_command(0x00);
                           //;Set Memory Addressing Mode Default => 0x02
                       //0x00 => Horizontal Addressing Mode
Write command(0xA6);
                           //Set Normal Display
Write_command(0xDB); //Set Deselect Vcomh level
Write command(0x3c): //~0.83xVCC
Write_command(0xA4);
                           //Entire Display ON
Write_command(0x81);
                           //Set Contrast Control for Bank 0
Write command(0xFF);
Write command(0xD5):
                           //SET DISPLAY CLOCK
Write_command(0xF0);
                           //105HZ
Write command(0xD8): //Select Area color ON/OFF
Write command(0x05); //MONO Mode and Low Power display Mode
Write command(0xA1); //Set Segment Re-Map Default => 0xA0
                       //0xA1 (0x01) => Column Address 0 Mapped to SEG131
Write command(0xC8); //Set COM Output Scan Direction Default => 0xC0
                       //0xC8 (0x08) => Scan from COM63 to 0
Write command(0xDA):
                           //Set COM Hardware Configuration
Write_command(0x12); //Alternative COM Pin
Write command(0xD9); //Set Pre-Charge period
Write command(0xF1); //Refer to SPEC 34PAGE
Write command(0xFF);
Write_command(0xAF); // Display ON
```

}

6.3 TOUCH PANEL's application code.

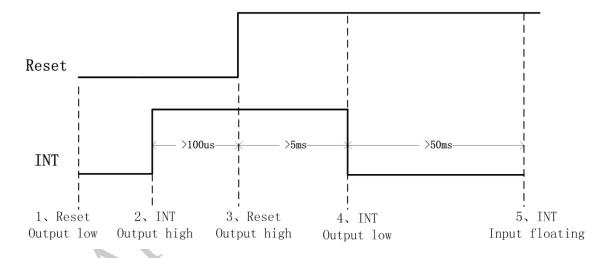
6.3.1

7-btis address	8-bits write address	8bits read address
0x5D	0xBA	0xBB
0x14	0x28	0x29

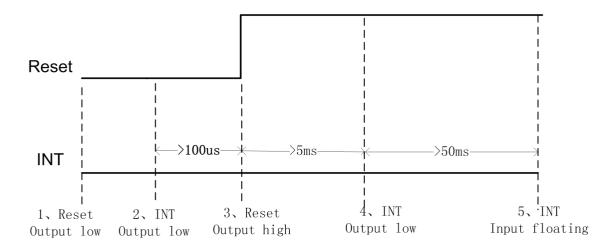
6.3.2 Power on for I2C address select

GT911 supports two I2C slave addresses: 0xBA/0xBB and 0x28/0x29. The host can select the address by changing the status of Reset and INT pins during the power-on initialization phase. See the diagram below for configuration methods and timings:

Timing for setting slave address to 0x28/0x29:



Timing for setting slave address to 0xBA/0xBB:



6.3.3 Register Map6.3.3.1 Real-time command (Write only)

Addr	Name	bit7	bit6	bit5	bit4	bit3	bit2	bit1	bit0
0x8040	Command	0: Read coordinates status; 1: Read diff data or raw data; 2: Read diff data or raw data; 3: Reference capacitance update (Internal test); 4: Reference capacitance calibratio (Internal test); 5: Screen off; 6: Enter Charge mode; 7: Exit Charge mode 8: Gesture mode. 0x20: Enter HotKnot Slave Approach mode 0x21: Enter HotKnot Master Approach mode 0x22: Enter Receive mode 0x28: Exit Slave Approach mode 0x28: Exit Slave Approach mode 0x29: Exit Master Approach mode 0x24: Exit Receive mode 0x2A: Exit Receive m						calibration	
0x8041	ESD_Check	ESD protection mechanism enabled; reset to 0 upon initialization; after that, driver writes 0xAA to 0x8040 and reads and checks the value of 0x8040 regularly.							
0x8046	Command_Check	For comn	For commands greater than 0x07, it is required to write the command to 0x8046 before writing to 0x8040, to improve anti-ESD capability.						

6.3.3.2 Configuration information (R/W)

Register	Config Data	bit7	bit6	bit5	bit4	bit3	bit2	bit1	bit0
		The version	on number of	configuratio	n documents	(configurat	ion paramet	ers will be u	pdated only
0x8047	Config_	when the version number of the new release is later than that of the previous one, or equal to that of							
0.0047	Version	the previous	one but there	e are changes	s in contents	; documents	are numbere	ed sequentia	lly from 'A' to
			'Z'	; Send 0x00	and the vers	sion number	is reset to 'A	۲')	
0x8048	X Output Max								
0.00010	(Low Byte)				Resolution	n of X axis			
0x8049	X Output Max				resoration	1 01 71 47115			
0.0019	(High Byte)								
0x804A	Y Output Max								
	(Low Byte)				Resolution	n of Y axis			
0x804B	Y Output Max								
	(High Byte)		_			_			
0x804C	Touch Number		Reserv	ved			ouch points		
		ъ.	9			X2Y	Sito		ring mechanism
0904D	Module_	Driver_	Sensor_	Ct	l	(X,Y	(0.0	00: rising 6	-
0x804D	Switch1	Resersal	Resersal (X2X)	Stretc	h_rank	axis switch-ov	(Software	01: falling 02: Low le	_
		(Y2Y)	(X2X)				noise reduction)	02: Low le	
						er)	reduction)	03: High is	5061
0.0045	Module_			FirstFilte		,	Approch_	HotKnot	Touch_
0x804E	switch2	Rese	Reserved r Dis Reserved		erved	En	_En	Key	
0x804F	Shake_Count		equency when			<u> </u>			ressing down
0x8050	Filter	First_	Filter		_	er threshold fo		rdinates, coe	fficient is 4)
0x8051	Large_Touch				mber of large	area touch po			
0x8052	Noise_		Reserv	ved		Noise red	luction value (0-15 valid, c	oefficient is 1)
	Reduction								
0x8053	Screen_			Thi	eshold for tou	ich to be detec	cted		
	Touch_Level								
0x8054	Screen_			Thi	reshold for to	ich to be relea	ised		
	Leave_Level					I14-			
0x8055	Low_Power_		Reserv	ved		Interval to	_		ption mode (0s
02056	Control	to 15s) Pulse width setting for gesture wakeup Coordinates report rate (period: 5+N ms)							
0x8056	Refresh_Rate		te output thresh						
0x8057	$x_{threshold}$	A coordinat	c output unesn	,		dinates contin		omiguicu to	o, GIFII WIII
		V coordinate o	nutnut threshold					figured to 0	GT911 will keen
0x8058	y_threshold	Y coordinate output threshold: 0-255 (Based on the last reported coordinates. If configured to 0, GT911 will keep outputting coordinates continuously)							
0x8059	X_Speed_Limit		outputting coordinates continuously)						
0x805A	Y_Speed_Limit	Reserved							
0/1005/1	optou_biiiit								

0x805B		Space of	border top	(coefficient	: 32)	Space	of border b	pottom (coefficient: 32)
0x805C	Space		Space of border left (coefficient: 32) Space of border right (c					
0x805D	Mini_Filter	1	Reser	`	,		configuration	n during line drawing process, d as 0 indicates 4
0x805E	Stretch R0			coe	fficient of St	retch space		
0x805F	Stretch_R1				efficient of S			
0x8060	Stretch_R2			co	efficient of S	Stretch space	3	
0x8061	Stretch_RM			The b	ase of multi	ple stretch sp	paces	
0x8062	Drv_GroupA_ Num	All_Driving	Res	served		Drive	r_Group_A	A_number
0x8063	Drv_GroupB_ Num	Reserve	ed	Dual_Fr eq		Drive	er_Group_E	3_number
0x8064	Sensor_Num	Sen		_B_Number				oup_A_Number
0x8065	FreqA_factor			•	actor of drive ock Multiplie			•
0x8066	FreqB_factor			-	actor of driv			-
0x8067	Pannel_ BitFreqL	Fundamenta	l Fraguence	of Driver C	Frounc A and	B (1526U7)	Fundamer	ntal Fraguency <14600Uz)
0x8068	Pannel_ BitFreqH	rundamenta	Fundamental Frequency of Driver Groups A and B (1526HZ< Fundamental Frequency <14600Hz)				nai Frequency <14000H2)	
0x8069	Pannel_Sensor_ TimeL	Output Interval	l between t	wo adjacent	drive signals	(unit: us); R	teserved (u	used in beta version; invalid
0x806A	Pannel_Sensor_ TimeH				in a Re	elease)		
0x806B	Pannel_Tx_ Gain	R	Reserved		Pannel_Dr F 4 gain config	R values,	I	Pannel_DAC_Gain 0: Gain max. 7: Gain min.
0x806C	Pannel_Rx_ Gain	Pannel_PG A_C	Pannel_	PGA_R	Pannel_F (4 gain confign	values,		Pannel_PGA_Gain in values, configurable)
0x806D	Pannel_Dump_ Shift	Amplification t	factor of ra		sture Mode	Amplific		r of raw data on the touch anel (2 ^N)
0x806E	Drv_Frame_ Control	Reserved	SubF	rame_DrvN	um (maximu	im setting is	17)	Repeat_Num (Accumulated sampling count)
0x806F	Charging_Level_U p		el. The leve	el applicable		node= origina	al level+co	ses the Touch_Level and nfiguration level. When iginal level.

0x8070	Module_ Switch3	Reserved	Gesture_ Hop_ Dis	Strong_S mooth	S		Res	served		Shape_En
0x8071	GESTURE_DIS	Valid d	istance for sl	ide-up/dov	vn wakeu	p	Valid distance for slide-left/right wakeup			eup
0x8072	Gesture_Long_ Press_Time		The gesture	recognizir	ng proces	sing abo	orting time	period wh	en long touching	
0x8073	X/Y_Slope_Adjust	when approxi	ment parame using "four p mation algor dinates (0: alg	point trigor ithm" to ca	nometric alculate th		The adjustment parameter of Y direction slope when using "four point trigonometric approximation algorithm" to calculate the coordinates (0: algorithm disabled)			netric
0x8074	Gesture_Control		ne for double ults to 1.5s v	-		I	Gestu	_	GA_Gain (8 gain [.] onfigurable)	values,
0x8075	Gesture_Switch1	Swipe left	Swipe up	Swipe right	,	w	o	m	e	С
0x8076	Gesture_Switch2	Swipe is valid only at the bottom of the TP	Z	s		^	>	V	Double-ta p	Swipe down
0x8077	Gesture_Refresh_R ate			Report	rate in G	esture r	ure mode (period is 5+ms)			
0x8078	Gesture_Touch_ Level			1	Touch threshold in Gesture mode					
0x8079	NewGreenWake UpLevel		Thre	shold for 1	NewGree	n wakeu	up of Gestu	re wakeup	function	
0x807A	Freq_Hopping_Star	Start freq	uency for fre		ind	licates10			is 2KHz, for exa	ample, 50
0x807B	Freq_Hopping_End	End frequ	ency for free		ind	icates 3	00KHz;		is 2KHz, for example for examp	nple, 150
0x807C	Noise_Detect_Time	(Number of frequency	t_Stay_Time f tests taken of point in each s recommend	on each noise	(Confirm	ned nois	Detect_Confirm_Times ed noise level after repeated noise tests, 1-63 valid; 20 is recommended)			valid; 20 is
0x807D	Hopping_Flag	Hopping_E n	Rang Ex		Dis_Fo rce_Ref	De	elay_Hoppii	ng	Detect_Time (timeout for noise unit: second), F	detection,
0x807E	Hopping_ Threshold	the interfer	oing_Limit: fa ence value or ng_Limit*4.	f current fr	equency	is greate	er than is limit f	(Condit	opping_Hit_Thresh tions for selecting : Current operating e- Minimum inter	optimal g frequency

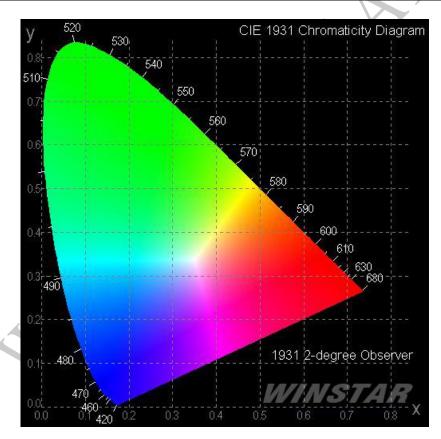
			valuex4, then optimal frequency is selected and frequency hopping is enabled)
0x807F	Noise_ Threshold	Threshold to distinguish if there is interference (if the inter this threshold, it is regarded as no inte	* * *
0x8080	Noise_Min_Thresh old	When ESD causes the minimum interference point to be greater reduction treatment. Configured to 0 means this function is disable higher) has the equivalent effect. To enable this function, it is received the minimum frequency point (LCD interference and common normal interference	ed and configured to high value (such as 200 or commended to set the value 5 to 20 higher than -mode interference, whichever is greater) in
0x8081	NC	Reserved	
0x8082	Hopping_Sensor_G roup	Sections for Hopping Frequency Noise Detection	on (4 sections recommended)
0x8083	Hopping_seg1_Nor malize	Seg1 Normalize coefficient (sampling va	lue *N / 128= Raw data)
0x8084	Hopping_seg1_Fact or	Seg1 Central point Fa	actor
0x8085	Main_Clock_Ajdus t	Fine adjustment of IC main clock Frequency,	within the range of -7 to +8
0x8086	Hopping_seg2_Nor malize	Seg2 Normalize coefficient (sampling val	ue *N / 128= Raw data)
0x8087	Hopping_seg2_Fact or	Seg2 Central point Fa	actor
0x8088	NC	Reserved	
0x8089	Hopping_seg3_Nor malize	Seg3 Normalize coefficient (sampling val	lue *N / 128= Raw data)
0x808A	Hopping_seg3_Fact or	Seg3 Central point Fa	actor
0x808B	NC	Reserved	
0x808C	Hopping_seg4_Nor malize	Seg4 Normalize coefficient (sampling val	lue *N / 128= Raw data)
0x808D	Hopping_seg4_Fact or	Seg4 Central point Fa	actor
0x808E	NC	Reserved	
0x808F	Hopping_seg5_Nor malize	Seg5 Normalize coefficient (sampling val	lue *N / 128= Raw data)
0x8090	Hopping_seg5_Fact or	Seg5 Central point Fa	actor
0x8091	NC	Reserved	
0x8092	Hopping_seg6_Nor malize	Seg6 Normalize coefficient (sampling val	lue *N / 128= Raw data)
0x8093	Key 1	Key 1 address: 0-255	valid

		(0 indicate	es no key is a			sses of all four	•	multiples of	8, it means
			independent key design manner.)						
					-	ss: 0-255 valid			
0x8094	Key 2	(0 indica	ites no key is			ess of all four	-	ultiples of 8,	it means
						y design manr			
					-	ss: 0-255 valid			
0x8095	Key 3	(0 indica	ites no key is	available. W	hen the addr	ess of all four	keys is the m	ultiples of 8,	it means
						y design manr			
					-	ss: 0-255 valid			
0x8096	Key 4	(0 indica	ites no key is			ess of all four		ultiples of 8,	it means
				inc	lependent ke	y design manr	ner)		
		Time limi	t for long-pr	ess update (1	s to 15s).	Key active ar	ea configuration	on (single side)	: 0-15 valid
0x8097	Key_Area	Long-press	ong-press update is disabled when configured						
			to	0.					
0x8098	Key_Touch_Level				Touch key t	ouch threshold	l		
0x8099	Key_Leave_Level			,	Fouch key re	elease threshol	d		
0x809A	Key_Sens	KeySen	s_1(sensitivity	coefficient of	Key 1)	KeySens	s_2 (sensitivit	y coefficient of	Key 2)
0x809B	Key_Sens	KeySen	s_3(sensitivity	coefficient of	Key 3)	KeySens	s_4 (sensitivit	y coefficient of	Key 4)
		The key	restrain interv	al after finge	er leaves	Independe	ent adjacent l	ey restrain p	arameter
0x809C	Key_Restrain	screen	(unit: 100ms	: 100ms), 0 means the key					
		suj	opression into	erval is 600m	s.				
0x809D	Key_Restrain_ Time		Rese	rved		slides to lea ms). Timin leaves the T this time into until the tou	y restrain time to the both of the both of the starts from FP. If there is the tounch key is relevant on the tount of the start of the	the moment touch key even hey will be cased and tou	that finger eent within e restrained ched down
	GESTURE_	Large-area	touch proce	ssing in Gest	ure mode (th	e size of the to			
0x809E	LARGE_TOUCH					is disabled.		, ,	
0x809F	NC				Res	served			
0x80A0	NC				Res	served			
0x80A1	Hotknot_Noise_ Map	Rese	erved	200K	250K	300K	350K	400K	450K
0x80A2	Link_Threshold			•	Link_Noi	seThreshold	•		•
0x80A3	Pxy_Threshold				Pxy_Nois	seThreshold			
0x80A4	GHot_Dump_ Shift		Reserved		Rx_Self	Ampl	ification fact	or of raw Dat	a (2 ^N)
0x80A5	GHot_Rx_Gain	PGA_C	PG	A_R	Res	served	-	Gain (8 level configured)	s to be
0x80A6	Freq_Gain0	1	al gain calibra s N/16. Inva				al gain calibra is N/16. Inval	_	

		2007/	250V signal asignalih mel 12 di 1
0x80A7	Freq_Gain1	300K signal gain calibration, calibration volume	350K signal gain calibration, calibration volume
		is N/16. Invalid when N=0.	is N/16. Invalid when N=0.
0x80A8	Freq Gain2	200K signal gain calibration, calibration volume	250K signal gain calibration, calibration volume
	-	is N/16. Invalid when N=0.	is N/16. Invalid when N=0.
0x80A9	Freq Gain3	Reserved	150K signal gain calibration, calibration volume
0.000115	Treq_Gams	10301,700	is N/16. Invalid when N=0.
0x80AA	NC	Rese	erved
0x80AB	NC	Rese	erved
0x80AC	NC	Rese	erved
0x80AD	NC	Reso	erved
0x80AE	NC	Reso	erved
0x80AF	NC	Reso	erved
0x80B0	NC	Rese	erved
0x80B1	NC	Rese	erved
0x80B2	NC	Rese	erved
		Distance for adjacent rectangles to be combined	
0x80B3	Combine_Dis	in Gesture mode	Distance for adjacent rectangles to be combined
0x80B4	Split_Set	Distance for a large-area rectangle to be split	Distance for a normal-size rectangle to be split
0x80B5	NC	Resc	erved
0x80B6	NC	Rese	erved
0x80B7	G GHO		_
to	Sensor_CH0 to	Channel number on chip co	orresponding to ITO Sensor
0x80C4	Sensor_CH13		
0x80C5			
to	NC	Rese	erved
0x80D4			
0x80D5	D : CTTO :		
to	Driver_CH0 to	Channel number on chip co	orresponding to ITO Driver
0x80EE	Driver_CH25	•	
0x80EF			
to	NC	Rese	erved
0x80FE			
		Configuration verification (checksum va	ulue of the bytes from 0x8047 to 0x80FE)
0x80FF	Config_Chksum		
0x8100	Config_Fresh	Configuration updated flag (the flag is written by the host)

7.Optical Characteristics

Item	Symbol	Condition	Min	Тур	Max	Unit
View Anglo	(V)θ	_	160	_	_	deg
View Angle	(Η)φ	_	160	_	_	deg
Contrast Ratio	CR	Dark	2000:1	_	V+	-
Doggoog Time	T rise	_	_	10		μs
Response Time	T fall	_	_	10	Y _	μs
Display with 509	% check Bo	pard Brightness	60	80	_	cd/m2
CIEx(Yellow)		(CIE1931)	0.45	0.47	0.49	_
CIEy(Yellow)		(CIE1931)	0.48	0.50	0.52	_



8.OLED Lifetime

ITEM	Conditions	Min	Тур	Remark
Operating Life Time	Ta=25°C / Initial 50% check board brightness Typical Value	50,000 Hrs	_	Note

Notes:

- 1. Life time is defined the amount of time when the luminance has decayed to <50% of the initial value.
- 2. This analysis method uses life data obtained under accelerated conditions to extrapolate an estimated probability density function (*pdf*) for the product under normal use conditions.
- 3. Screen saving mode will extend OLED lifetime.

9.Reliability

Content of Reliability Test

Environmenta	T		Applicable
Test Item	Content of Test	Test Condition	Standard
High Temperature storage	Endurance test applying the high storage temperature for a long time.	80°C 240hrs	_ >
Low Temperature storage	Endurance test applying the low storage temperature for a long time.	-30°C 240hrs	-45
High Temperature Operation	Endurance test applying the electric stress (Voltage & Current) and the thermal stress to the element for a long time.	70°C 240hrs	7.9
Low Temperature Operation	Endurance test applying the electric stress under low temperature for a long time.	-20°C 240hrs	
High Temperature/ Humidity Storage	Endurance test applying the high temperature and high humidity storage for a long time.	60°C,90%RH 240hrs	
High Temperature/ Humidity Operation	Endurance test applying the high temperature and high humidity Operation for a long time.	60°C,90%RH 120hrs	
Temperature Cycle	Endurance test applying the low and high temperature cycle30°C 25°C 80°C 30min 5min 30min	-30°C /80°C 30 cycles	
Mechanical Tes	st		
Vibration test	Endurance test applying the vibration during transportation and using.	Frequency:10~55Hz amplitude:1.5mm Time:0.5hrs/axis Test axis:X,Y,Z	
Others			
Static electricity test	Endurance test applying the electric stress to the finished product housing.	Air Discharge model ±4kv,10 times	

^{***} Supply voltage for OLED system =Operating voltage at 25°C

Test and measurement conditions

- 1. All measurements shall not be started until the specimens attain to temperature stability. After the completion of the described reliability test, the samples were left at room temperature for 2 hrs prior to conducting the failure test at 23±5°C; 55±15% RH.
- 2. All-pixels-on is used as operation test pattern.
- 3. The degradation of Polarizer are ignored for High Temperature storage, High Temperature/ Humidity Storage, Temperature Cycle

Evaluation criteria

- 1. The function test is OK.
- 2. No observable defects.
- 3. Luminance: > 50% of initial value.
- 4. Current consumption: within ± 50% of initial value.

APPENDIX:

RESIDUE IMAGE

Because the pixels are lighted in different time, the luminance of active pixels may reduce or differ from inactive pixels. Therefore, the residue image will occur. To avoid the residue image, every pixel needs to be lighted up uniformly.

10.Inspection specification

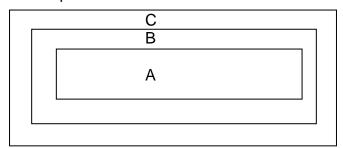
Inspection Standard:

MIL-STD-105E table normal inspection single sample level II.

Definition

- 1 Major defect: The defect that greatly affect the usability of product.
- 2 Minor defect: The other defects, such as cosmetic defects, etc.

Definition of inspection zone:



Zone A: Active Area

Zone B: Viewing Area except Zone A

Zone C: Outside Viewing Area

Note: As a general rule, visual defects in Zone C are permissible, when it is no trouble of quality and assembly to customer's product.

Inspection Methods

- 1 The general inspection: Under fluorescent light illumination: 750~1500 Lux, about 30cm viewing distance, within 45° viewing angle, under 25±5°C.
- 2 The luminance and color coordinate inspection: By SR-3 or BM-7 or the equal equipments, in the dark room, under 25±5°C.

NO	Item	Criterion	AQL
01	Electrical Testing	 1.1 Missing vertical, horizontal segment, segment contrast defect. 1.2 Missing character, dot or icon. 1.3 Display malfunction. 1.4 No function or no display. 1.5 Current consumption exceeds product specifications. 1.6 OLED viewing angle defect. 1.7 Mixed product types. 1.8 Contrast defect. 	0.65
02	Black or white spots on OLED (display only)	 2.1 White and black spots on display ≤ 0.25mm, no more than three white or black spots present. 2.2 Densely spaced: No more than two spots or lines within 3mm. 	2.5

NO	Item	Criterion				
	OLED black spots, white spots, contaminati on (non- display)	3.1 Round type : As following drawing Φ=(x+y)/2 → X	SIZE $\Phi \le 0.10$ $0.10 < \Phi \le 0.20$ $0.20 < \Phi \le 0.25$ $0.25 < \Phi$	Acceptable QTY Accept no dense 2 1	Zone A+ B, A+ B A+ B	2.5
03		3.2 Line type : (As	n Width W≦0.02 0 0.02 <w≤0.0< td=""><td>Acceptable Q TY Accept no dense</td><td>Zone A+B A+B A+B</td><td>2.5</td></w≤0.0<>	Acceptable Q TY Accept no dense	Zone A+B A+B A+B	2.5
04	Polarizer bubbles	If bubbles are visible, judge using black spot specifications, not easy to find, must check in specify direction.	Size Φ $\Phi \le 0.20$ $0.20 < \Phi \le 0.50$ $0.50 < \Phi \le 1.00$ $1.00 < \Phi$ Total Q TY	Acceptable Q TY Accept no dense 3 2 0 3	Zone A+B A+B A+B A+B	2.5
05	Scratches	Follow NO.3 OLEI	D black spots, whit	e spots, contamina	tion.	

NO	Item	Criterion	AQL
		Symbols Define: x: Chip length y: Chip width z: Chip thickness k: Seal width t: Glass thickness a: OLED side length L: Electrode pad length: 6.1 General glass chip: 6.1.1 Chip on panel surface and crack between panels:	
06	Chipped glass	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	2.5
		6.1.2 Corner crack: z: Chip thickness	
		⊙ If there are 2 or more chips, x is the total length of each chip.Symbols :	
		x: Chip length y: Chip width z: Chip thickness k: Seal width t: Glass thickness a: OLED side length L: Electrode pad length 6.2 Protrusion over terminal: 6.2.1 Chip on electrode pad:	
06	Glass crack	Z	2.5
		$\begin{array}{ c c c c c c }\hline y: Chip \ width & x: Chip \ length & z: Chip \ thickness \\ y & \leq 0.5 mm & x \leq 1/8a & 0 < z \leq t \\ \hline \end{array}$	

NO	Item	Criterion	AQL
		6.2.2 Non-conductive portion:	
06	Glass crack	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	2.5
07	Cracked glass	The OLED with extensive crack is not acceptable.	2.5
08	Backlight elements	8.1 Illumination source flickers when lit.8.2 Spots or scratched that appear when lit must be judged.Using OLED spot, lines and contamination standards.	0.65 2.5
		8.3 Backlight doesn't light or color wrong.	0.65
09	Bezel	9.1 Bezel may not have rust, be deformed or have fingerprints, stains or other contamination.9.2 Bezel must comply with job specifications.	2.5 0.65
		10.1 COB seal may not have pinholes larger than 0.2mm or	2.5
10	PCB, COB	contamination. 10.2 COB seal surface may not have pinholes through to the IC. 10.3 The height of the COB should not exceed the height indicated in the assembly diagram. 10.4 There may not be more than 2mm of sealant outside the seal area on the PCB. And there should be no more than three places.	2.5 0.65 2.5
		10.5 No oxidation or contamination PCB terminals.10.6 Parts on PCB must be the same as on the production characteristic chart. There should be no wrong parts, missing parts or excess parts.	2.5 0.65
		10.7 The jumper on the PCB should conform to the product characteristic chart.	0.65
		10.8 If solder gets on bezel tab pads, OLED pad, zebra pad or screw hold pad, make sure it is smoothed down.	2.5

NO	Item	Criterion	AQL
11	Soldering	 11.1 No un-melted solder paste may be present on the PCB. 11.2 No cold solder joints, missing solder connections, oxidation or icicle. 11.3 No residue or solder balls on PCB. 11.4 No short circuits in components on PCB. 	2.5 2.5 2.5 0.65
12	General appearance	 12.1 No oxidation, contamination, curves or, bends on interface Pin (OLB) of TCP. 12.2 No cracks on interface pin (OLB) of TCP. 12.3 No contamination, solder residue or solder balls on product. 12.4 The IC on the TCP may not be damaged, circuits. 12.5 The uppermost edge of the protective strip on the interface pin must be present or look as if it cause the interface pin to sever. 12.6 The residual rosin or tin oil of soldering (component or chip component) is not burned into brown or black color. 12.7 Sealant on top of the ITO circuit has not hardened. 12.8 Pin type must match type in specification sheet. 12.9 OLED pin loose or missing pins. 12.10 Product packaging must the same as specified on packaging specification sheet. 12.11 Product dimension and structure must conform to product specification sheet. 	2.5 0.65 2.5 2.5 2.5 2.5 0.65 0.65 0.65 0.65

Check Item	Classification	Criteria
No Display	Major	
Missing Line	Major	
Pixel Short	Major	
Darker Short	Major	
Wrong Display	Major	
Un-uniform B/A x 100% < 70% A/C x 100% < 70%	Major	A Normal B Dark Pixel C Light Pixel

11.Precautions in use of OLED Modules

Modules

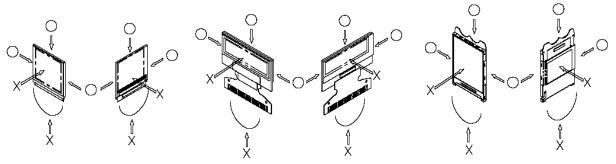
- (1) Avoid applying excessive shocks to module or making any alterations or modifications to it.
- (2)Don't make extra holes on the printed circuit board, modify its shape or change the components of OLED display module.
- (3)Don't disassemble the OLED display module.
- (4)Don't operate it above the absolute maximum rating.
- (5)Don't drop, bend or twist OLED display module.
- (6)Soldering: only to the I/O terminals.
- (7)Storage: please storage in anti-static electricity container and clean environment.
- (8)It's pretty common to use "Screen Saver" to extend the lifetime and Don't use fix information for long time in real application.
- (9)Don't use fixed information in OLED panel for long time, that will extend "screen burn" effect time.
- (10) Winstar has the right to change the passive components, including R2 and R3 adjust resistors. (Resistors, capacitors and other passive components will have different appearance and color caused by the different supplier.)
- (11)Winstar have the right to change the PCB Rev. (In order to satisfy the supplying stability, management optimization and the best product performance...etc, under the premise of not affecting the electrical characteristics and external dimensions, Winstar have the right to modify the version.)

11.1. Handling Precautions

- (1) Since the display panel is being made of glass, do not apply mechanical impacts such us dropping from a high position.
- (2) If the display panel is broken by some accident and the internal organic substance leaks out, be careful not to inhale nor lick the organic substance.
- (3) If pressure is applied to the display surface or its neighborhood of the OLED display module, the cell structure may be damaged and be careful not to apply pressure to these sections.
- (4) The polarizer covering the surface of the OLED display module is soft and easily scratched. Please be careful when handling the OLED display module.
- (5) When the surface of the polarizer of the OLED display module has soil, clean the surface. It takes advantage of by using following adhesion tape.
 - * Scotch Mending Tape No. 810 or an equivalent
 - Never try to breathe upon the soiled surface nor wipe the surface using cloth containing solvent such as ethyl alcohol, since the surface of the polarizer will become cloudy.

Also, pay attention that the following liquid and solvent may spoil the polarizer:

- * Water
- * Ketone
- * Aromatic Solvents
- (6) Hold OLED display module very carefully when placing OLED display module into the System housing. Do not apply excessive stress or pressure to OLED display module. And, do not over bend the film with electrode pattern layouts.
 - These stresses will influence the display performance. Also, secure sufficient rigidity for the outer cases.



- (7) Do not apply stress to the LSI chips and the surrounding molded sections.
- (8) Do not disassemble nor modify the OLED display module.
- (9) Do not apply input signals while the logic power is off.
- (10) Pay sufficient attention to the working environments when handing OLED display modules to prevent occurrence of element breakage accidents by static electricity.
- * Be sure to make human body grounding when handling OLED display modules.
- * Be sure to ground tools to use or assembly such as soldering irons.
- * To suppress generation of static electricity, avoid carrying out assembly work under dry environments.
- * Protective film is being applied to the surface of the display panel of the OLED display module. Be careful since static electricity may be generated when exfoliating the protective film.
- (11) Protection film is being applied to the surface of the display panel and removes the protection film before assembling it. At this time, if the OLED display module has been stored for a long period of time, residue adhesive material of the protection film may remain on the surface of the display panel after removed of the film. In such case, remove the residue material by the method introduced in the above Section 5.
- (12) If electric current is applied when the OLED display module is being dewed or when it is placed under high humidity environments, the electrodes may be corroded and be careful to avoid the above.

11.2. Storage Precautions

(1) When storing OLED display modules, put them in static electricity preventive bags avoiding exposure to direct sun light nor to lights of fluorescent lamps. and, also, avoiding high temperature and high humidity environment or low temperature (less than 0°C) environments.

(We recommend you to store these modules in the packaged state when they were shipped from Winstar.

At that time, be careful not to let water drops adhere to the packages or bags nor let dewing occur with them.

(2) If electric current is applied when water drops are adhering to the surface of the OLED display module, when the OLED display module is being dewed or when it is placed under high humidity environments, the electrodes may be corroded and be careful about the above.

11.3. Designing Precautions

- (1) The absolute maximum ratings are the ratings which cannot be exceeded for OLED display module, and if these values are exceeded, panel damage may be happen.
- (2) To prevent occurrence of malfunctioning by noise, pay attention to satisfy the VIL and VIH specifications and, at the same time, to make the signal line cable as short as possible.
- (3) We recommend you to install excess current preventive unit (fuses, etc.) to the power circuit (VDD). (Recommend value: 0.5A)
- (4) Pay sufficient attention to avoid occurrence of mutual noise interference with the neighboring devices.
- (5) As for EMI, take necessary measures on the equipment side basically.

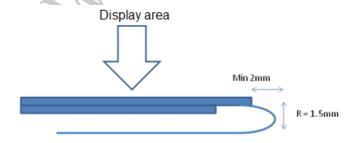
- (6) When fastening the OLED display module, fasten the external plastic housing section.
- (7) If power supply to the OLED display module is forcibly shut down by such errors as taking out the main battery while the OLED display panel is in operation, we cannot guarantee the quality of this OLED display module.
- * Connection (contact) to any other potential than the above may lead to rupture of the IC.

11.4. Precautions when disposing of the OLED display modules

1) Request the qualified companies to handle industrial wastes when disposing of the OLED display modules. Or, when burning them, be sure to observe the environmental and hygienic laws and regulations.

11.5. Other Precautions

- (1) When an OLED display module is operated for a long of time with fixed pattern may remain as an after image or slight contrast deviation may occur.
- Nonetheless, if the operation is interrupted and left unused for a while, normal state can be restored. Also, there will be no problem in the reliability of the module.
- (2) To protect OLED display modules from performance drops by static electricity rapture, etc., do not touch the following sections whenever possible while handling the OLED display modules.
- * Pins and electrodes
- * Pattern layouts such as the TCP & FPC
- (3) With this OLED display module, the OLED driver is being exposed. Generally speaking, semiconductor elements change their characteristics when light is radiated according to the principle of the solar battery. Consequently, if this OLED driver is exposed to light, malfunctioning may occur.
- * Design the product and installation method so that the OLED driver may be shielded from light in actual usage.
- * Design the product and installation method so that the OLED driver may be shielded from light during the inspection processes.
- (4) Although this OLED display module stores the operation state data by the commands and the indication data, when excessive external noise, etc. enters into the module, the internal status may be changed. It therefore is necessary to take appropriate measures to suppress noise generation or to protect from influences of noise on the system design.
- (5) We recommend you to construct its software to make periodical refreshment of the operation statuses (re-setting of the commands and re-transference of the display data) to cope with catastrophic noise.
- (6) Resistors, capacitors and other passive components will have different appearance and color caused by the different supplier.
- (7) Our company will has the right to upgrade and modify the product function.
- (8) The limitation of FPC and Film bending.



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